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Substitute for form 1449A/PTO Complete if Known APPLICATION NUMBER 10/666,527 INFORMATION DISCLOSURE **FILING DATE** 09/18/2003 STATEMENT BY APPLICANT **FIRST NAMED** Bailey et al. **INVENTOR** Group Art Unit 1756 (use as many sheets as necessary) **Examiner Name** Unassigned Sheet 8 1 PA51-22-02 Attorney Docket Number

		U.S. Patent Do			Date of Publication of	Pages, Columns, Lines,	
Examiner Initials*	Cite No. ¹	Number	Kind Code ² (# known)	Name of Patentee or Applicant of Cited Document	Cited Document MM-DD-YYYY	Where Relevant Passages or Relevant Figures Appear	
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Signature Considered

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Sheet	2	of	8	Examiner Name	Unassigned
				Attorney Docket Number	PA51-22-02

		-	<u> </u>	U.S. PATENT DOCUMEN	TS	
Examiner Initials*	Cite No. ¹	U.S. Patent Do	Kind Code ² (if known)	Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document MM-DD-YYYY	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
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aminer	Cite	U.S. Patent D	ocument Kind Code ²	Name of Patentee or Applicant	Date of Publication of	Pages, Columns, Lines, Where Relevant	
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d	B69	6,716,754	B2	Hofmann et al.	4/6/2004		
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FL	_ B72	5,601,641	<u> </u>	Stephens	2/11/1997		
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317		DIAFFL	JOAN	FIRST NAMED INVENTOR	Bailey et al.	
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				U.S. PATENT DOCUMEN	TS	
examiner nitials*	Cite No.1	U.S. Patent D	Nind Code ² (if known)	Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document MM-DD-YYYY	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
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317	A I EIVIEN I	BY APP	LICANI	FIRST NAMED INVENTOR Bailey et al.				
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			Fſ	JREIGI	N PATENT DOCUMENTS		
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Sheet	7	of	8	Examiner Name	Unassigned	
	1			Attorney Docket Number	PA51-22-02	

B88	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published. Chou, Nanoimprint Lithography and Lithographically Induced Self-Assembly, MRS Bulletin, pp. 512 - 517, 7/1/2001 Colburn et al., Step and Flash Imprint Lithography for sub-100 nm Patterning, Proceedings of SPIE Vol. 3997, pp. 453 - 457, 1/1/2000 Chou et al., Imprint Lithography with Sub-10 nm Feature Size and High Throughput, Microelectronic Engineering 35, pp. 237 - 240, 1/1/1997	T ²
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Chou et al., Ultrafast and Direct Imprint of Nanostructures in Silicon, Nature, Col. 417, (June

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INFO	RMATION	DISCLO	SURE	APPLICATION NUMBER	10/666,527	
STATEMENT BY APPLICANT				FILING DATE	09/18/2003	
				FIRST NAMED INVENTOR	Bailey et al.	
(use	e as many sheets	as necessary	<i>(</i>)	Group Art Unit	1756	
Sheet	8	of	8	Examiner Name	Unassigned	
	.1	·	_ 1	Attorney Docket Number	PA51-22-02	

OTHER PRIO	V WVI .	NON PATENT LITERATURE DOCUMENTS	
Examiner Initials*	Cite No.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T²
EC	B97	Chou et al., Nanoimprint Lithography, Journal of Vacuum Science Technology B 14(16), pp. 4129-4133, 11/1/1996	T

Ei	B97	Chou et al., Nanoimprint Lithography, Journal of Vacuum Science Technolgoy B 14(16), pp. 4129-4133, 11/1/1996
GC	B98	Colburn et al., Development and Advantages of Step-and-Flash Lithography, Solid State Technology, 7/1/2001
EL	B99	Resnick et al., High Resolution Templates for Step and Flash Imprint Lithography, Journal of Microlithography, Microfabrication, and Microsystems. Vol 1. No. 3., 10/1/2002
GL	B100	Colburn et al., Characterization and Modeling of Volumetric and Mechanical Properties for Step and Flash Imprint Lithography Photopolymers, Journal of Vacuum Science Technology. Vol b. 19(6), 11/1/2001
ひし	B101	Bailey et al., Step and Flash Imprint Lithography: Defect Analysis, Journal of Vacuum Science, B 19(6), pp. 2806-2810, 11/1/2001
A	B102	Bailey et al., Step and Flash Imprint Lithography: Template Surface Treatment and Defect Analysis, Journal of Vacuum Science, B 18(6), pp. 3572-3577, 11/1/2000
EL	B103	Wronosky et al., Wafer and Reticle Positioning System for the Extreme Ultraviolet Lithography Engineering Test Stand, Emerging Lithography Technologies, Proceedings of SPIE Vol. 3997, pp. 829-839, 7/1/2000
EC	B104	Schneider et al., Stripes of Partially Fluorinated Alkyl Chains: Dipolar Langmuir Monolayers

Examiner Signature		Date Considered	2/6/06
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^{*}Examiner: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

¹ Applicant's unique citation designation number (optional). ² Applicant is to place a check mark here if English language Translation is attached. This collection of information is required by 37 CFR 1.97 and 1.98. The information is required to obtain or retain a benefit by the public which is to file (and by the USPTO to process) an application. Confidentiality is governed by 35 U.S.C. 122 and 37 CFR 1.14. This collection is estimated to take 2 hours to complete, including gathering, preparing, and submitting the completed application form to the USPTO. Time will vary depending on the individual case. Any comments on the amount of time you require to complete this form and/or suggestions for reducing this burden, should be sent to the Chief Information Officer, U.S. Patent and Trademark Office, P.O. Box 1450, Alexandria VA 22313-1450... DO NOT SEND FEES OR COMPLETED FORMS TO THIS ADDRESS. SEND TO: Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450.

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	IFORMATION			APPLICATION NUMBER	10/666,527	
.	IAIEMENI	DI APPLI	CANT	FILING DATE	09/18/2003	
(u	se as many shee	ets as necessa	ry)	FIRST NAMED INVENTOR	Bailey et al.	
				Group Art Unit	1756	
Sheet	1	of	4	Examiner Name	Unassigned	
			•	Attorney Docket Number	PA51-22-02	

				U.S. PATENT DOCUMEN	TS	
Examiner Initials*			Tello code		Date of Publication of Cited Document MM-DD-YYYY	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
W	C1	5,206,983	1	Guckel et al.	5/4/1993	
a	C2	6,117,708		Wensel	9/12/2000	
El	C3	6,316,290	B1	Wensel	11/13/2001	
FU	C4	6,387,787	B1	Mancini et al.	5/14/2002	
Hi	C5	2004/0021866	A1	Watts et al.	2/5/2004	
Vil	C6	2004/0022888	A1	Sreenivasan et al.	2/5/2004	
C	C7	2003/0205657	A1	Voisin	11/6/2003	
60	C8	2004/0124566	A1	Sreenivasan et al.	7/1/2004	
110	C9	6,665,119	B1	Kurtz et al.	12/16/2003	
FL	C10	6,190,929	B1	Wang et al.	2/20/2001	
EL.	C11	4,512,848		Deckman et al.	4/23/1985	
4,5	C12	2005/0067379	A1	Sreenivasan et al.	3/31/2005	
EU	C13	2004/0250945	A1	Zheng et al.	12/16/2004	
N	C14	5,477,058		Sato	12/19/1995	
80	C15	2005/0084804	A1	Truskett et al.	4/21/2005	
Ec	C16	2005/0037143	A1	Chou et al.	2/17/2005	
a	C17	2005/0098534	A1	Sreenivasan et al.	5/12/2005	

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Substitute for form 1449A/PTO				Comple	Complete if Known		
	IFORMATIO			APPLICATION NUMBER	10/666,527		
STATEMENT BY APPLICANT				FILING DATE	09/18/2003		
(u	se as many she	ets as necessa	ny)	FIRST NAMED INVENTOR	Bailey et al.		
		1 .	· 1 4	Group Art Unit	1756		
Sheet	2	of	4	Examiner Name	Unassigned		
				Attorney Docket Number	PA51-22-02		

U.S. PATENT DOCUMENTS								
Examiner Initiats*	Cite No.1	U.S. Patent D Number	Kind Code ² (if known)	Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document MM-DD-YYYY	Pages, Cotumns, Lines, Where Relevant Passages or Relevant Figures Appear		
Ü	C18	6,900,881	T	Sreenivasan et al.	5/31/2005			
P	C19	6,902,853		Sreenivasan et al.	6/7/2005			
U	C20	6,890,688	B2	Mancini et al.	5/10/2005			
El	C21	6,908,861	B2	Sreenivasan et al.	6/21/2005			
00	C22	6,916,584	B2	Sreenivasan et al.	7/12/2005			
W	C23	2003/0062334	A1	Lee et al.	4/3/2003			
a	C24	6,932,934	B2	Choi et al.	8/23/2005			
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	ORMATION ATEMENT B			APPLICATION NUMBER	10/666,527	
31	AIEMENID	TAPPLIC	ANI	FILING DATE	09/18/2003	
(use	as many sheets	as necessar,	y)	FIRST NAMED INVENTOR	Bailey et al.	
				Group Art Unit	1756	
Sheet 3 of 4		Examiner Name	Unassigned			
	<u> </u>		<u>. L.</u>	Attorney Docket Number	PA51-22-02	

OTHER PRI	OR ART	NON PATENT LITERATURE DOCUMENTS	,
Examiner Initials*	Cite No.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T²
CC	C25	MOON ET AL., Interferometric-Spatial-Phase Imaging for Six-Axis Mask Control, MIT NanoStructures Laboratory, Research Laboraty of Electronics 10/17/2003	
EC	C26	SHIBUICHI ET AL., Super Water- and Oil-Repellent Surfaces Resulting from Fractal Structure, Journal of Colloid and Interface Science, Vol. 208, no. 1, pp. 287-294 12/1/1998	
Ec	C27	PARK ET AL., Aligning Liquid Crystals Using Replicated Nanopatterns, PSI Scientific Report 2002, Vol VII, p. 85 3/1/2003	
Ø	C28	TANIGUCHI ET AL., Diamond Nanoimprint Lithography, Nanotechnology, 2002, vol. 13, no. 5, pp. 592-596(5) 1/1/2002	
El	C29	KIYOHARA ET AL., Abstract of Plasma Etching of CVD Diamond Films using an ECR-type Oxygen Source, http://www.iop.org/EJ/abstract/0957-4484/10/4/304 9/26/2003	
EC	C30	APPLICATION NO. 11/126,946, naming Inventors Choi et al., entitled Formation of Discontinuous Films During an Imprint Lithography Process, filed 5/11/2005	
4	C31	APPLICATION NO. 11/127,041, naming Inventors Sreenivasan et al., entitled Step and Repeat Imprint Lithography Processes, filed 5/11/2005	
H	C32	APPLICATION NO. 11/127,060, naming Inventors Sreenivasan et al., entitled Step and Repeat Imprint Lithography Systems, filed 5/11/2005	
1/6	C33	APPLICATION NO. 11/136,897, naming Inventors Miller et al., entitled Imprint Lithography Template Having a Coating to Reflect and/or Absorb Actinic Energy, filed 5/25/2005	

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Applicant's unique citation designation number (optional). Applicant is to place a check mark here if English language Translation is attached. This collection of Information is required by 37 CFR 1.97 and 1.98. The information is required to obtain or retain a benefit by the public which is to file (and by the USPTO to process) an application. Confidentiality is governed by 35 U.S.C. 122 and 37 CFR 1.14. This collection is estimated to take 2 hours to complete, including gathering, preparing, and submitting the completed application form to the USPTO. Time will vary depending on the individual case. Any comments on the amount of time you require to complete this form and/or suggestions for reducing this burden, should be sent to the Chief Information Officer, U.S. Patent and Trademark Office, P.O. Box 1450, Alexandria, VA 22313-1450.. DO NOT SEND FEES OR COMPLETED FORMS TO THIS ADDRESS. SEND TO: Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450.

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	ORMATION			APPLICATION NUMBER	10/666,527	
51/	ATEMENT B	1 APPLIC	ANI	FILING DATE	09/18/2003	
(use	as many sheets	as necessary	y)	FIRST NAMED INVENTOR	Bailey et al.	
				Group Art Unit	1756	
Sheet	4	of	4	Examiner Name	Unassigned	
	1	J		Attorney Docket Number	PA51-22-02	

OTHER PRIO	OTHER PRIOR ART - NON PATENT LITERATURE DOCUMENTS							
Examiner Initials*	Cite No.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	Τ²					
W	C34	THOMPSON ET AL., Fabrication of Step and Flash Imprint Lithography Templates Using Commercial Mask Processes, SPIE Microlithography Conference 2/1/2003						
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Applicant's unique ditation designation number (optional). Applicant is to place a check mark here if English language Translation is attached.

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				Attorney Docket Number	PA51-22-02		

	U.S. PATENT DOCUMENTS									
Examiner Initials*	Cite No.'	U.S. Patent Document Kind Code ² Number (if known)		Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document MM-DD-YYYY	Pages, Cotumns, Lines, Where Relevant Passages or Relevant Figures Appear				
Et	D1	4,959,252	<u> </u>	Bonnebat et al.	9/25/1990					
60	D2	5,218,193		Miyatake	6/8/1993					
KI	D3	5,259,926		Kuwabara et al.	9/9/1993					
U	D4	5,348,616		Hartman et al.	9/20/1994					
E	D5	5,355,219		Araki et al.	10/11/1994					
Er	D6	5,512,131		Kumar et al.	4/30/1996					
AC	D7	5,545,367		Bae et al.	8/13/1996					
EL	D8	5,952,127		Yamanaka	9/14/1999					
A	D9	6,051,345		Huang	4/18/2000					
No.	D10	6,137,562		Masuyuki et al.	10/24/2000					
El	D11	6,420,892	B1	Krivy et al.	7/16/2002					
El	D12	2004/0112861	A1	Choi et al.	6/17/2004	, , , , , , , , , , , , , , , , , , ,				
EC	D13	2003/0092261	A1	Kondo et al.	5/15/2003					
EL	D14	2003/0179354	A1	Araki et al.	9/25/2003					
EL	D15	2002/0150398	A1	Choi et al.	10/17/2002					
6	D16	2004/0146792	A1	Nimmakayala et al.	7/29/2004					
a	D17	4,201,800		Alcom et al.	5/6/1980					

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				Attorney Docket Number	PA51-22-02	

	U.S. PATENT DOCUMENTS									
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a	D18	6,770,852	B1	Stegner	8/3/2004					
A	D19	2003/0081193		White et al.	5/1/2003					
Fil	.D20	2004/0150129		Hougham et al.	8/5/2004					
101	D21	2004/0202865		Homola et al.	10/14/2004					
FL	D22	5,937,758		Maracas et al.	8/17/1999					
EL	D23	5,726,548		Chiba et al.	3/10/1998					
EL	D24	2002/0069525	A1	Hada et al.	6/13/2002					
ec	D25	5,508,527		Kuroda et al.	4/16/1996					
P.C	D26	5,876,550		Feygin et al.	3/2/1999					
GL	D27	5,785,918		Hull	7/28/1998					
EL	D28	5,171,490		Fudim	12/15/1992					
FL	D29	4,964,145		Maldonado	10/16/1990					
EL-	D30	4,887,283		Hosno	12/12/1989					
Ei	D31	5,155,749		DiMilia et al.	10/13/1992					
ec	D32	5,504,793		Chen	4/2/1996					
EC	D33	6,580,505		Bareket	6/17/2003					
Ec	D34	6,753,131	B1	Rogers et al.	6/22/2004					

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				Attorney Docket Number	PA51-22-02	

				U.S. PATENT DOCUMEN	TS	
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W.	1	I	1		l amamaa.	
	D35	2004/0189994	A1	Sreenivasan et al.	9/30/2004	
OL	D36	6,819,426	B2	Sezginer et al.	11/16/2004	
TIC.	D37	2004/0223131	A1 .	Choi et al.	11/11/2004	
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K	D47	6,916,585	B2 .	Sreenivasan et al.	7/12/2005	
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H	. D49	2005/0051742	A1	Shiraishi	3/10/2005	
Él	D50	6,153,886		Hagiwara et al.	11/28/2000	
CC	D51	5,853,446		Carre et al.	12/29/1998	

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•••	IFORMATIO			APPLICATION NUMBER	10/666,527	
3	IMIEMENI	DI APPLI	CANI	FILING DATE	09/18/2003	
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		1	1	Group Art Unit	1756	
Sheet	4	of	11.	Examiner Name	Unassigned	
				Attorney Docket Number	PA51-22-02	

				U.S. PATENT DOCUMEN	TS	
Examiner Initials*	Cite No.1	U.S. Patent (Nind Code ² (if known)	Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document MM-DD-YYYY	Pages, Cotumns, Lines, Where Relevant Passages or Relevant Figures Appear
E.	D52	6,251,207	B1	Schultz et al.	6/26/2001	
ÉC	D53	5,331,371		Mori et al.	7/19/1994	
Ec	D54	6,929,762	B2	Rubin	8/16/2005	
	D55	6,849,558	B2	Schaper	2/1/2005	
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Substitute for form 1449A/PTO				Complete if Known		
	NFORMATIO	ON DISCLO	SURE	APPLICATION NUMBER	10/666,527	
	STATEMENT			FILING DATE	09/18/2003	
				FIRST NAMED INVENTOR	Bailey et al.	
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Examiner Initials*	Cite No.1	Office	Number ⁴	Kind Code ⁵ (if knBown)	Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document MM-DD-YYYY	Where Relevant Passages or Relevant Figures Appear	100
EC	D56	wo	87/02935		Long et al.	5/21/1987		Γ
Ü	D57	JP	1-196749		Matsumoto et al.	8/8/1989		
EC	D58	JP	02192045		Mineo et al.	7/27/1990		
EC	D59	wo	01/90816		Heidari	11/29/2001	•	
EC	D60	wo	02/22916		Pettersson et al.	3/21/2002		
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EC	D62	EP	1460738	A2	Gimkiewicz et al.	9/22/2004		
CC	D63	JP	61-40845		Matsuo et al.	2/27/1986		
EC	D64	JP	2-248480		Yoneda et al.	10/4/1990	<u> </u>	
E	_D65	JP	3-90345		Nobuyoshi et al.	4/16/1991		L
EL	-D66	JP	9-278490		Toru et al.	10/28/1997		
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Substitute for	form 1449A/F	गठ		Comple	te if Known
	ORMATION ATEMENT B			APPLICATION NUMBER	10/666,527
317	ALEMENI D	TAPPLIC	MINI	FILING DATE	09/18/2003
(use	as many sheets	as necessar,	v)	FIRST NAMED INVENTOR	Bailey et al.
				Group Art Unit	1756
Sheet	6	of	11	Examiner Name	Unassigned
	*		·	Attorney Docket Number	PA51-22-02

OTHER PRIC	OR ART	- NON PATENT LITERATURE DOCUMENTS	
Examiner Initials*	Cite No.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T²
	<u> </u>	ARAI ET AL., Development of a New Parallel Manipulator with Fixed Linear Actuator, In	
Æ	D67	Proceedings of Japan/USA Symposium on Flexible Automation, Vol. 1, ASME, New York, pp. 145–149 1/1/1996	
A	D68	WILLIAMS ET AL., Six Degree of Freedom Mag-Lev Stage Development, SPIE Vol. 3051, 856-867 1/1/1997	
É	D69	RONG ET AL., Design and Analysis of Flexure-Hinge Mechanism Used in Micro-Positioning Stages, ASME Vol. 2, pp.979-985 1/1/1994	
ÉC	D70	FEYNMAN, There's Plenty of Room at the Bottom, 12/1/1959	
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EL	D69	Stages, ASME Vol. 2, pp.979-985 1/1/1994
ÉC	D70	FEYNMAN, There's Plenty of Room at the Bottom, 12/1/1959
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EL	_D75	Abstract of Japanese Patent 55-88332, 4/14/2004

Examiner Signature	mel	Date Considered	2/6/06

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Substitute for form 1449A/PTO				Complé	ete if Known
	ORMATION			APPLICATION NUMBER	10/666,527
STATEMENT BY APPLICANT (use as many sheets as necessary)				FILING DATE	09/18/2003
				FIRST NAMED INVENTOR	Bailey et al.
				Group Art Unit	1756
Sheet	7	of	11	Examiner Name	Unassigned
		*		Attorney Docket Number	PA51-22-02

OTHER PR	OR ART	- NON PATENT LITERATURE DOCUMENTS	
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EC	D76	Abstract of Japanese Patent 02-92603, 8/12/2004	
Ü	D77	Abstract of Japanese Patent 02-24848, 1/26/1990	
EL	D78	SOWAH, Diamond used to Break the Mould, Retrieved 9/2/2003 from URL: http://www.electronictimes.com/story/OEG20020918S0003 9/18/2002	
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EC	D82	APPLICATION NO. 10/858,179, naming Inventors Choi et al., entitled Compliant Device for Nano-scale Manufacturing, filed 6/1/2004	
EC	_ D83	APPLICATION NO. 10/858,100, naming Inventors Choi et al., entitled Method and System to Control Movement of a Body for Nano-Scale Manufacturing, filed 6/1/2004	
7	D84	APPLICATION NO. 10/827,118, naming Inventors Watts et al., entitled A Method of Forming a Deep-Featured Template Employed in Imprint Lithography, filed 4/19/2004	

	Examiner Signature	Date Considered	2/6/06
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INFORMATION DISCLOSURE STATEMENT BY APPLICANT				APPLICATION NUMBER	10/666,527
				FILING DATE	09/18/2003
(use	as many sheets	as necessary	v)	FIRST NAMED INVENTOR	Bailey et al.
				Group Art Unit	1756
Sheet	8	of	11	Examiner Name	Unassigned
		<u> </u>		Attorney Docket Number	PA51-22-02

OTHER PR	OR ART	NON PATENT LITERATURE DOCUMENTS	
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	1	1 ADDI 1047104440 40/000 000 and a language Observation of the Control of the Con	γ
EC	D85	APPLICATION NO. 10/999,898, naming Inventors Cherala et al., entitled System for Magnification and Distortion Correction during Nano-Scale Manufacturing, filed 11/30/2004	
Á	D86	APPLICATION NO. 11/000,331, naming Inventors Nimmakayala et al., entitled Interferometric Analysis for the Manufacture of Nano-Scale Devices, filed 11/30/2004	
EL	D87	APPLICATION NO. 11/000,321, naming Inventors Nimmakayala et al., entitled Interferometric Analysis Method for the Manufacture of Nano-Scale Devices, filed 11/30/2004	
EL	D88	DENG ET AL., Simulation of Exposure and Alignment for Nano-imprint Lithography, Proc. SPIE, vol. 4688-93, p. 842-849 1/1/2002	
ÉC	D89	DENG ET AL., Rigorous Electromagnetic Simulation Applied to Alignment Systems, Proc. SPIE, vol. 4346-164, p. 1533-1540 1/1/2001	
EC	D90	APPLICATION NO. 11/143,076, naming Inventors Cherala et al., entitled System and Method for Improvement of Alignment and Overlay for Microlithography, filed 6/2/2005	
Œ	D91	APPLICATION NO. 11/142,808, naming Inventors Cherala et al., entitled System for Varying Dimensions of a Substrate during Nano-Scale Manufacturing, filed 6/1/2005	
A	D92	APPLICATION NO. 11/142,834, naming Inventors Cherala et al., entitled Method of Varying Dimensions of a Substrate during Nano-Scale Manufacturing, filed 6/1/2005	
G.	D93	APPLICATION NO. 11/142,838, naming Inventors Choi et al., entitled Compliant Device for Nano-Scale Manufacturing, filed 6/1/2005	

Examiner Signature	Juy	Dat Con	te nsidered	2/6/26

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STATEMENT BY APPLICANT				FILING DATE	09/18/2003
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				Group Art Unit	1756
Sheet	9	of	11	Examiner Name	Unassigned
				Attorney Docket Number	PA51-22-02

OTHER PRI	OR ART -	NON PATENT LITERATURE DOCUMENTS	
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EC	D94	APPLICATION NO. 11/142,839, naming Inventors Cherala et al., entitled Apparatusa to Vary Dimensions of a Substrate during Nano-Scale Manufacturing, filed 6/1/2005	
A	D95	APPLICATION NO. 11/142,825, naming Inventors Choi et al., entitled Method and System to Control Movement of a Body for Nano-Scale Manufacturing, filed 6/1/2005	
A	D96	Abstract of Japanese Patent 61-040845, 2/27/1986	
ÉL	D97	Abstract of Japanese Patent 02-248480, 10/4/1990	
El	D98	Abstract of Japanese Patent 3-090345, 4/16/1991	
EC	D99	Abstract of Japanese Patent 09-278490, 10/28/1997	
ā	D100	Abstract of Japanese Patent 61-040845, 2/27/1986	
EC	D101	Abstract of Japanese Patent 02-248480, 10/4/1990	
EU	D102	CHOI ET AL., Distortion and Overlay Performance of UV Step and Repeat Imprint Lithography, MNE Micro- and Nano-Engineering Conference 9/1/2004	

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EC	D103	GEHOSKI ET AL., Indium Tin Oxide Template Development for Step and Flash Imprint Lithgraphy, SPIE Microlithography Conference 2/1/2005	
CC	D104	DAUKSHER ET AL., Repair of Step and Flash Imprint Lithography Templates, J. Vac. Sci. Technol. B 22(6), pp. 3306-3311 11/1/2004	
EC	D105	NORDQUIST ET AL., Image Placement Issues for ITO-based Step and Flash Imprint Lithography Templates, J. Vac. Sci. Technol. B, pp. 695-701 3/1/2004	
Ex	D106	GEHOSKI ET AL., Evaluation of the Imprio 100 Step and Flash Imprint Lithography Tool, Proceedings of SPIE, vol. 5374, pp. 1006-1016 5/1/2004	
Œ	D107	DAUKSHER ET AL., Step and Flash Imprint Lithography Template Characterization, from an Etch Perspective, J. Vac. Sci. Technol. B 21(6), pp. 2771-2776 11/1/2003	
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	ORMATION ATEMENT B			APPLICATION NUMBER	10/666,527
Ş1.	AIEMENI D	MPPLIC	FILING DATE	09/18/2003	
(use	as many sheets	as necessary	v)	FIRST NAMED INVENTOR	Bailey et al.
				Group Art Unit	1756
Sheet	11	of	11	Examiner Name	Unassigned
	1			Attorney Docket Number	PA51-22-02

OR ART -	NON PATENT LITERATURE DOCUMENTS	
Cite No.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T²
D112	NORDQUIST ET AL.Q, Critical Dimension and Image Placement Issues for Step and Flash Imprint Lithography Templates, 22nd Annual BACUS Symposium on Photomask Technology, Monterey, CA 9/1/2002	
D113	BAILEY ET AL., Template Fabrication Schemes for Step and Flash Imprint Lithography, Microelectronic Engineering, 61-62, pp. 461-467 1/1/2002	
D114	RESNICK ET AL., High Resolution Templates for Step and Flash Imprint Lithography, SPIE Microlithography Conference 2/1/2002	
D115	RESNICK ET AL., New Methods for Fabricating Step and Flash Imprint Lithography Templates, NIST-SPIE Conference on Nanotechnology 9/1/2001	
D116	CHOI ET AL., Layer-to-Layer Alignment for Step and Flash Imprint Lithography, SPIE's 26th Intl. Symp. Microlithography: Emerging Lithographic Technologies, Santa Clara, CA 3/1/2001	
	D112 D113 D114 D115	No. item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published. NORDQUIST ET AL.Q, Critical Dimension and Image Placement Issues for Step and Flash Imprint Lithography Templates, 22nd Annual BACUS Symposium on Photomask Technology, Monterey, CA 9/1/2002 BAILEY ET AL., Template Fabrication Schemes for Step and Flash Imprint Lithography, Microelectronic Engineering, 61-62, pp. 461-467 1/1/2002 RESNICK ET AL., High Resolution Templates for Step and Flash Imprint Lithography, SPIE Microlithography Conference 2/1/2002 RESNICK ET AL., New Methods for Fabricating Step and Flash Imprint Lithography Templates, NIST-SPIE Conference on Nanotechnology 9/1/2001 CHOI ET AL., Layer-to-Layer Alignment for Step and Flash Imprint Lithography, SPIE's 26th Intl.

Examiner Signature	Curlin		Date Considered	1/6/06

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